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IAP12 Rec'd PCT/PTO 18 JAN 2006

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| U.S. DEPARTMENT OF COMMERCE PATENT AND TRADEMARK OFFICE | | | |
| INFORMATION DISCLOSURE STATEMENT | | Docket Number: 10191/4062 | |
| Application Number To Be Assigned | Filing Date Herewith | Examiner | Art Unit |
| Invention Title IMPACT SENSOR AND METHOD FOR TESTING AN IMPACT SENSOR | | Inventor(s) RECKNAGEL et al. | |

Address to:


Commissioner for Patents
P. O. Box 1450
Alexandria, VA 22313-1450

- I. In accordance with the duty of disclosure under 37 C.F.R. § 1.56 and in conformance with the procedures of 37 C.F.R. §§ 1.97 and 1.98 and M.P.E.P. § 609, attorney for Applicants hereby brings the following references to the attention of the Examiner. The references are listed on the attached modified PTO Form No. 1449. It is respectfully requested that the information be expressly considered during the prosecution of this application, and that these references be made of record therein and appear among the "References Cited" on any patent to issue therefrom.
- II. A copy of each patent, publication or other information listed on the modified PTO form 1449 is enclosed, except as otherwise indicated on the modified PTO form 1449.

Dated:

11/18/06

By:


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| INFORMATION DISCLOSURE STATEMENT BY APPLICANT PTO FORM 1449 | Atty. Docket No. 10191/4062 | Serial No. To Be Assigned |
| | Applicant(s) RECKNAGEL et al. | |
| | Filing Date Herewith | Group To Be Assigned |

U. S. PATENT DOCUMENTS

| EXAMINER'S INITIALS | PATENT NUMBER | PATENT DATE | NAME | CLASS | SUBCLASS | FILING DATE |
|------------------------|------------------|----------------|----------------|-------|----------|----------------|
| | 5,513,878* | May 7, 1996 | Furui et al. | | | |
| | 6,470,249* | Oct. 22, 2002 | Mader et al. | | | |
| | 5,506,454* | April 9, 1996 | Hanzawa et al. | | | |
| | | | | | | |

FOREIGN PATENT DOCUMENTS

| EXAMINER'S INITIALS | DOCUMENT NUMBER | DATE | COUNTRY | CLASS | SUB-CLASS | TRANSLATION | |
|------------------------|--------------------|---------------|---------|-------|-----------|-------------|----|
| | | | | | | YES | NO |
| | 100 07 422 | Sept. 6, 2001 | DE | | | X* | |
| | 101 22 922 | Nov. 14, 2002 | DE | | | X* | |
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*Copy of reference is not enclosed because reference is cited in Search Report (copy of reference provided by International Searching Authority).

OTHER DOCUMENTS

| | | |
|---|-----------------|--|
| EXAMINER'S INITIALS | | AUTHOR, TITLE, DATE, PERTINENT PAGES, ETC. |
| | | |
| | | |
| EXAMINER | DATE CONSIDERED | |
| EXAMINER: Initial if citation considered, whether or not citation is in conformance with M.P.E.P. 609; draw line through citation if not in conformance and not considered. Include copy of this form with next communication to applicant. | | |